Search Notes			

1	Application/Control No.	Applicant(s)/Patent unde Reexamination	r
	10/766,018	NAYA ET AL.	
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۱,	Marcos D. Pizarro-Cresno	2814	

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257	3,9	6/8/2006	MDP
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SEARCH NOT (INCLUDING SEARCH)
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EAST search made of record for paper no. 11/05.	11/11/2005	MDP
Updated EAST search for paper no. 6/2006.	6/8/2006	MDP
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